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Kind regards,

Team Nexperia



# **PBSS8110Y**

# 100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor Rev. 02 — 21 November 2009

Product data sheet

#### **Product profile** 1.

### 1.1 General description

NPN low V<sub>CEsat</sub> transistor in a SOT363 (SC-88) plastic package.

#### 1.2 Features

- SOT363 package
- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High efficiency reduces heat generation

### 1.3 Applications

- Major application segments:
  - Automotive 42 V power
  - Telecom infrastructure
  - Industrial
- Peripheral driver:
  - ◆ Driver in low supply voltage applications (e.g. lamps and LEDs)
  - ◆ Inductive load driver (e.g. relays, buzzers and motors)
- DC-to-DC converter

### 1.4 Quick reference data

Table 1. Quick reference data

| Symbol             | Parameter                 | Conditions | Min | Тур | Max | Unit |
|--------------------|---------------------------|------------|-----|-----|-----|------|
| $V_{CEO}$          | collector-emitter voltage |            | -   | -   | 100 | V    |
| I <sub>C</sub>     | collector current (DC)    |            | -   | -   | 1   | Α    |
| I <sub>CM</sub>    | peak collector current    |            | -   | -   | 3   | Α    |
| R <sub>CEsat</sub> | equivalent on-resistance  |            | -   | -   | 200 | mΩ   |



100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

### 2. Pinning information

Table 2. Discrete pinning

| Table 2.   | Discrete piliting |                    |                |
|------------|-------------------|--------------------|----------------|
| Pin        | Description       | Simplified outline | Symbol         |
| 1, 2, 5, 6 | collector         |                    |                |
| 3          | base              | 654                | 1, 2, 5, 6<br> |
| 4          | emitter           |                    | 3 —            |
|            |                   | 0                  | 4              |
|            |                   | ∐1 ∐2 <u></u> 3    | sym014         |
|            |                   |                    |                |

## 3. Ordering information

Table 3. Ordering information

| Type number | Package |  |         |
|-------------|---------|--|---------|
|             | Name    | Description                              | Version |
| PBSS8110Y   | -       | plastic surface mounted package; 6 leads | SOT363  |

## 4. Marking

Table 4. Marking

| Type number | Marking code <sup>[1]</sup> |
|-------------|-----------------------------|
| PPBSS8110Y  | 81*                         |

<sup>[1] \* =</sup> p: made in Hong Kong

## 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol           | Parameter                    | Conditions                  | Min          | Max | Unit |
|------------------|------------------------------|-----------------------------|--------------|-----|------|
| $V_{CBO}$        | collector-base voltage       | open emitter                | -            | 120 | V    |
| $V_{CEO}$        | collector-emitter voltage    | open base                   | -            | 100 | V    |
| $V_{EBO}$        | emitter-base voltage         | open collector              | -            | 5   | V    |
| I <sub>CM</sub>  | peak collector current       | $T_{j(max)}$                | -            | 3   | Α    |
| I <sub>C</sub>   | continuous collector current |                             | -            | 1   | Α    |
| I <sub>B</sub>   | continuous base current      |                             | -            | 0.3 | Α    |
| P <sub>tot</sub> | total power dissipation      | $T_{amb} \leq 25~^{\circ}C$ | <u>[1]</u> - | 290 | mW   |
|                  |                              |                             | [2] -        | 480 | mW   |
|                  |                              |                             | [3]          | 625 | mW   |

<sup>\* =</sup> t: made in Malaysia

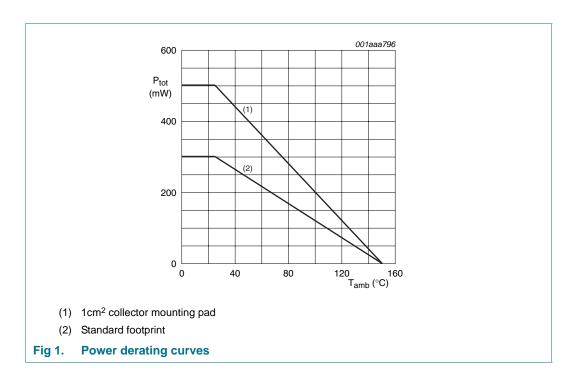
<sup>\* =</sup> W: made in China

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**Table 5.** Limiting values ...continued
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol    | Parameter                     | Conditions | Min             | Max  | Unit |
|-----------|-------------------------------|------------|-----------------|------|------|
| Tj        | junction temperature          |            | -               | 150  | °C   |
| $T_{amb}$ | operating ambient temperature |            | <del>-</del> 65 | +150 | °C   |
| $T_{stg}$ | storage temperature           |            |                 | +150 | °C   |

- [1] Device mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, standard footprint.
- [2] Device mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, 1cm<sup>2</sup> collector mounting pad.
- [3] Device mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, 6cm<sup>2</sup> collector mounting pad.



### 6. Thermal characteristics

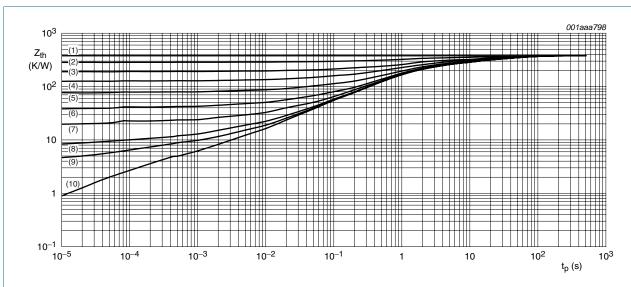
Table 6. Thermal characteristics

| Symbol        | Parameter   | Conditions  | Тур              | Unit |
|---------------|---|-------------|------------------|------|
| $R_{th(j-a)}$ | thermal resistance from junction                    | in free air | [ <u>1]</u> 431  | K/W  |
|               | to ambient  |             | [ <u>2</u> ] 260 | K/W  |
|               |   |             | [ <u>3]</u> 200  | K/W  |
| $R_{th(j-s)}$ | thermal resistance from junction to soldering point | in free air | <u>[1]</u> 85    | K/W  |

- [1] Device mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, standard footprint.
- [2] Device mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, 1cm<sup>2</sup> collector mounting pad.
- [3] Device mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, 6cm<sup>2</sup> collector mounting pad.

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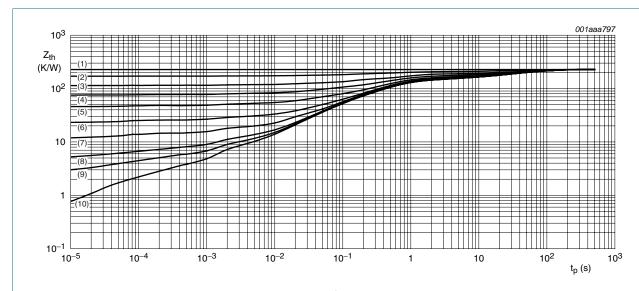


Mounted on FR4 PCB; standard footprint

- (1)  $\delta = 1$
- (2)  $\delta = 0.75$
- (3)  $\delta = 0.5$
- (4)  $\delta = 0.33$
- (5)  $\delta = 0.2$
- (6)  $\delta = 0.1$
- (7)  $\delta = 0.05$
- (8)  $\delta = 0.02$
- (9)  $\delta = 0.01$
- (10)  $\delta = 0$

Fig 2. Transient thermal impedance as a function of pulse time; typical values

100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor



Mounted on FR4 PCB; mounting pad for collector = 1cm<sup>2</sup>

- (1)  $\delta = 1$
- (2)  $\delta = 0.75$
- (3)  $\delta = 0.5$
- (4)  $\delta = 0.33$
- (5)  $\delta = 0.2$
- (6)  $\delta = 0.1$
- (7)  $\delta = 0.05$
- (8)  $\delta = 0.02$
- (9)  $\delta = 0.01$
- (10)  $\delta = 0$

Fig 3. Transient thermal impedance as a function of pulse time; typical values

### 7. Characteristics

Table 7. Characteristics

 $T_i = 25 \, ^{\circ}\text{C}$  unless otherwise specified.

| Symbol           | Parameter                            | Conditions  | Min            | Тур | Max | Unit |
|------------------|--------------------------------------|---|----------------|-----|-----|------|
| $I_{CBO}$        | collector-base cut-off               | $V_{CB} = 80 \text{ V}; I_{E} = 0 \text{ A}$                                | -              | -   | 100 | nA   |
| current          |                                      | $V_{CB} = 80 \text{ V}; I_E = 0 \text{ A};$<br>$T_j = 150 ^{\circ}\text{C}$ | -              | -   | 50  | μΑ   |
| I <sub>CES</sub> | collector-emitter<br>cut-off current | $V_{CE} = 80 \text{ V}; V_{BE} = 0 \text{ V}$                               | -              | -   | 100 | nA   |
| I <sub>EBO</sub> | emitter-base cut-off current         | $V_{EB} = 4 \text{ V}; I_{C} = 0 \text{ A}$                                 | -              | -   | 100 | nA   |
| h <sub>FE</sub>  | DC current gain                      | $V_{CE} = 10 \text{ V}; I_{C} = 1 \text{ mA}$                               | 150            | -   | -   |      |
|                  |                                      | $V_{CE} = 10 \text{ V}; I_{C} = 250 \text{ mA}$                             | 150            | -   | 500 |      |
|                  |                                      | $V_{CE} = 10 \text{ V}; I_{C} = 0.5 \text{ A}$                              | <u>[1]</u> 100 | -   | -   |      |
|                  |                                      | $V_{CE} = 10 \text{ V}; I_{C} = 1 \text{ A}$                                | <u>[1]</u> 80  | -   | -   |      |

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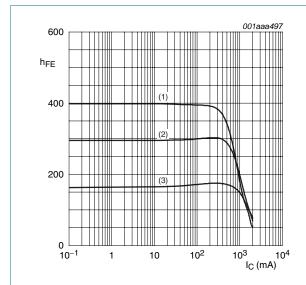
100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

Table 7. Characteristics ... continued

 $T_i = 25$  °C unless otherwise specified.

| ,                  | •                               |   |              |     |      |      |
|--------------------|---------------------------------|---|--------------|-----|------|------|
| Symbol             | Parameter                       | Conditions  | Min          | Тур | Max  | Unit |
| $V_{\text{CEsat}}$ | collector-emitter               | $I_C = 100 \text{ mA}; I_B = 10 \text{ mA}$                     | -            | -   | 40   | mV   |
|                    | saturation voltage              | $I_C = 500 \text{ mA}; I_B = 50 \text{ mA}$                     | -            | -   | 120  | mV   |
|                    |                                 | $I_C = 1 \text{ A}; I_B = 100 \text{ mA}$                       | -            | -   | 200  | mV   |
| R <sub>CEsat</sub> | equivalent<br>on-resistance     | $I_C = 1 A; I_B = 100 \text{ mA}$                               | <u>[1]</u> - | 160 | 200  | mΩ   |
| $V_{BEsat}$        | base-emitter saturation voltage | $I_C = 1 A; I_B = 100 \text{ mA}$                               | -            | -   | 1.05 | V    |
| $V_{BEon}$         | base-emitter turn-on voltage    | $V_{CE} = 10 \text{ V}; I_{C} = 1 \text{ A}$                    | -            | -   | 0.9  | V    |
| f <sub>T</sub>     | transition frequency            | $V_{CE} = 10 \text{ V; } I_{C} = 50 \text{ mA;}$<br>f = 100 MHz | 100          | -   | -    | MHz  |
| C <sub>c</sub>     | collector capacitance           | $V_{CB} = 10 \text{ V}; I_E = I_e = 0 \text{ A};$<br>f = 1 MHz  | -            | -   | 7.5  | pF   |
|                    |                                 |   |              |     |      |      |

[1] Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 



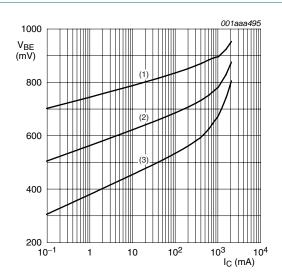


<sup>(1)</sup>  $T_{amb} = 100 \, ^{\circ}C$ 

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

(3)  $T_{amb} = -55 \, ^{\circ}C$ 

Fig 4. DC current gain as a function of collector current; typical values

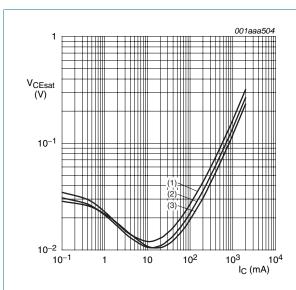


$$V_{CE} = 10 \text{ V}$$

- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 5. Base-emitter voltage as a function of collector current; typical values

100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor



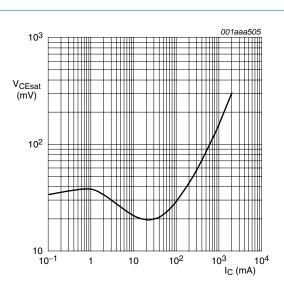
$$I_{\rm C}/I_{\rm B} = 10$$

(1) 
$$T_{amb} = 100 \, ^{\circ}C$$

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

(3)  $T_{amb} = -55 \, ^{\circ}C$ 

Fig 6. Collector-emitter saturation voltage as a function of collector current; typical values



 $I_C/I_B = 20$ ;  $T_{amb} = 25$  °C

Fig 7. Collector-emitter saturation voltage as a function of collector current; typical values

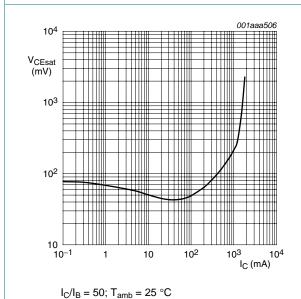
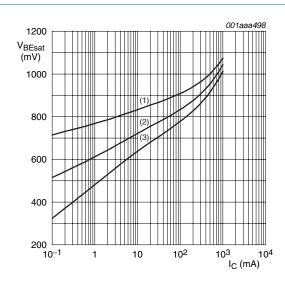


Fig 8. Collector-emitter saturation voltage as a function of collector current; typical values



 $I_{\rm C}/I_{\rm B} = 10$ 

(1)  $T_{amb} = -55 \, ^{\circ}C$ 

(2)  $T_{amb} = 25 \, ^{\circ}C$ 

(3)  $T_{amb} = 100 \, ^{\circ}C$ 

Fig 9. Base-emitter saturation voltage as a function of collector current; typical values

100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

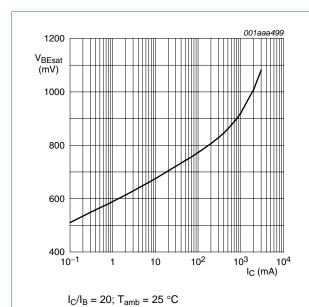


Fig 10. Base-emitter saturation voltage as a function of collector current; typical values

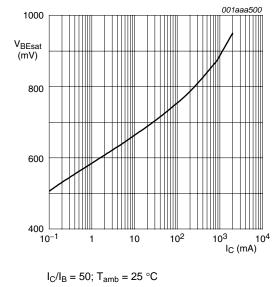


Fig 11. Base-emitter saturation voltage as a function of collector current; typical values

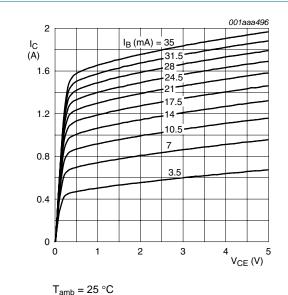
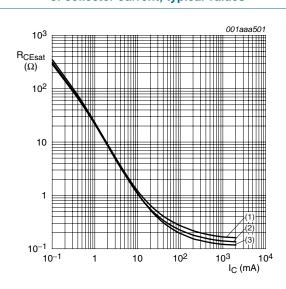


Fig 12. Collector current as a function of collector-emitter voltage; typical values



 $I_{\rm C}/I_{\rm B}=10$ 

(1)  $T_{amb} = 100 \, ^{\circ}C$ 

(2)  $T_{amb} = 25 \, ^{\circ}C$ 

(3)  $T_{amb} = -55 \, ^{\circ}C$ 

Fig 13. Equivalent on-resistance as a function of collector current; typical values

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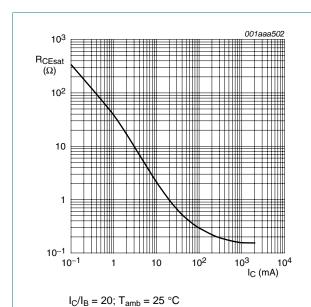


Fig 14. Equivalent on-resistance as a function of collector current; typical values

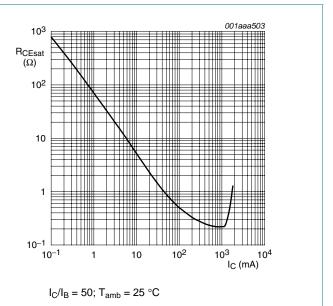


Fig 15. Equivalent on-resistance as a function of collector current; typical values

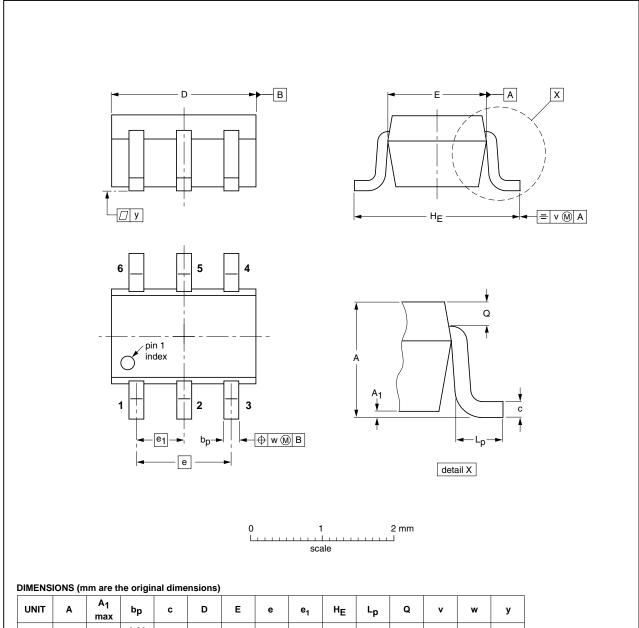
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100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

# Package outline

### Plastic surface-mounted package; 6 leads

**SOT363** 



| UNIT | A          | A <sub>1</sub><br>max | bp           | С            | D          | E            | е   | e <sub>1</sub> | HE         | Lp           | ď            | V   | w   | у   |
|------|------------|-----------------------|--------------|--------------|------------|--------------|-----|----------------|------------|--------------|--------------|-----|-----|-----|
| mm   | 1.1<br>0.8 | 0.1                   | 0.30<br>0.20 | 0.25<br>0.10 | 2.2<br>1.8 | 1.35<br>1.15 | 1.3 | 0.65           | 2.2<br>2.0 | 0.45<br>0.15 | 0.25<br>0.15 | 0.2 | 0.2 | 0.1 |

| OUTLINE |     | REFER | ENCES | EUROPEAN   | ISSUE DATE                      |
|---------|-----|-------|-------|------------|---------------------------------|
| VERSION | IEC | JEDEC | JEITA | PROJECTION | ISSUE DATE                      |
| SOT363  |     |       | SC-88 |            | <del>04-11-08</del><br>06-03-16 |

Fig 16. Package outline

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## 9. Revision history

### Table 8. Revision history

| Document ID    | Release date                                     | Data sheet status   | Change notice           | Supersedes                |  |  |  |  |
|----------------|--|---|-------------------------|---------------------------|--|--|--|--|
| PBSS8110Y_2    | 20091121   | Product data  | -                       | PBSS8110Y_1               |  |  |  |  |
| Modifications: | including new lo                                 | was changed to reflect the egal definitions and disclair  | ' '                     | ,                         |  |  |  |  |
|                | <ul> <li>Table 2 "Discre</li> </ul>              | te pinning": amended  |                         |                           |  |  |  |  |
|                | <ul> <li>Figure 4 "DC cu</li> </ul>              | urrent gain as a function of  | collector current; typi | cal values": updated      |  |  |  |  |
|                |  | ctor-emitter saturation volta<br>it unit amended from mV to   |                         | ollector current; typical |  |  |  |  |
|                | <ul> <li>Figure 12 "Colle<br/>updated</li> </ul> | • Figure 12 "Collector current as a function of collector-emitter voltage; typical values": updated |                         |                           |  |  |  |  |
|                | <ul> <li>Figure 16 "Pacl</li> </ul>              | kage outline": updated  |                         |                           |  |  |  |  |
| PBSS8110Y_1    | 20040602   | Product data  | -                       | -                         |  |  |  |  |

100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

### 10. Legal information

#### 10.1 Data sheet status

| Document status[1][2]          | Product status[3] | Definition  |
|--------------------------------|-------------------|---|
| Objective [short] data sheet   | Development       | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification     | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production        | This document contains the product specification.                                     |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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**PBSS8110Y NXP Semiconductors** 

### 100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

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2N5769 2SC2412KT146S 2SC5490A-TL-H 2SD1816S-TL-E 2SD1816T-TL-E CMXT2207 TR CPH6501-TL-E MCH4021-TL-E
US6T6TR NJL0281DG 732314D CMXT3906 TR CPH3121-TL-E CPH6021-TL-H 873787E IMZ2AT108 UMX21NTR MCH6102-TL-E
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